



1 Cover Page

# RF Exposure Evaluation Report

**Application No.:** SHEM2006004766CR  
**FCC ID:** 2ATEV-BL1206-P  
**IC:** 25062-BL1206P  
**Applicant:** Hangzhou BroadLink Technology Co., Ltd.  
**Address of Applicant:** Room 101,1/F,Unit C,Building 1,No.57 Jiang'er Road,Changhe Street,Binjiang District,Hangzhou,Zhejiang,P.R.China  
**Manufacturer:** Hangzhou BroadLink Technology Co., Ltd.  
**Address of Manufacturer:** Room 101,1/F,Unit C,Building 1,No.57 Jiang'er Road,Changhe Street,Binjiang District,Hangzhou,Zhejiang,P.R.China  
**Factory:** Hangzhou Gubei Intelligent Manufacturing Co., Ltd.  
**Address of Factory:** D218,Phase II, Hangzhou Xiaoshan (China) Hardware Machinery Science and Technology Innovation Park, Liansan Cun, Yiqiao Zhen,, Xiaoshan District, Hangzhou, Zhejiang, P.R.China  
**Equipment Under Test (EUT):**  
**EUT Name:** BroadLink  
**Model No.:** BL1206-P  
**Standard(s) :** FCC Rules 47 CFR §2.1091  
KDB447498 D01 General RF Exposure Guidance v06  
RSS-102 Issue 5 (March 2015)  
**Date of Receipt:** 2020-06-16  
**Date of Test:** 2020-06-17 to 2020-07-02  
**Date of Issue:** 2020-07-03

<b>Test Result:</b>	<b>Pass*</b>
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\* In the configuration tested, the EUT complied with the standards specified above.

Parlan Zhan

Parlan Zhan  
E&E Section Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.



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**Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com**

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Revision Record			
Version	Description	Date	Remark
00	Original	2020-07-03	/

Authorized for issue by:				
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		Bill Wu / Project Engineer		
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		Parlam Zhan / Reviewer		



## 2 Contents

	Page
<b>1 COVER PAGE.....</b>	<b>1</b>
<b>2 CONTENTS .....</b>	<b>3</b>
<b>3 GENERAL INFORMATION .....</b>	<b>4</b>
3.1 GENERAL DESCRIPTION OF E.U.T. ....	4
3.2 TECHNICAL SPECIFICATIONS .....	4
3.3 TEST LOCATION .....	5
3.4 TEST FACILITY.....	5
<b>4 TEST STANDARDS AND LIMITS .....</b>	<b>6</b>
4.1 FCC RADIOFREQUENCY RADIATION EXPOSURE LIMITS: .....	6
4.2 IC RADIOFREQUENCY RADIATION EXPOSURE LIMITS: .....	6
<b>5 MEASUREMENT AND CALCULATION .....</b>	<b>7</b>
5.1 MAXIMUM TRANSMIT POWER .....	7
5.2 MPE CALCULATION .....	8



### 3 General Information

#### 3.1 General Description of E.U.T.

Power supply:	DC4.5V ~24V
Serial Number:	24DFA7F25FA3
Firmware Version:	1206-P IV0

#### 3.2 Technical Specifications

Antenna Gain:	1dBi
Antenna Type:	PCB Antenna
Channel Spacing:	5MHz
Modulation Type:	802.11b: DSSS (CCK, DQPSK, DBPSK) 802.11g/n: OFDM (64QAM, 16QAM, QPSK, BPSK)
Data Rate:	802.11b: 1/2/5.5/11Mbps 802.11g: 6/9/12/18/24/36/48/54Mbps 802.11n: MCS0-MCS7
Number of Channels:	802.11b/g/n(HT20): 11 802.11n(HT40): 7
Operation Frequency:	802.11b/g/n(HT20): 2412MHz to 2462MHz 802.11n(HT40): 2422MHz to 2452MHz



### 3.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shanghai Branch

588 West Jindu Road, Xinqiao, Songjiang, 201612 Shanghai, China.

Tel: +86 21 6191 5666

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### 3.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L0599)**

CNAS has accredited SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **NVLAP (LAB CODE: 201034-0)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. is accredited by the National Voluntary Laboratory Accreditation Program (NVLAP).

- **FCC (Designation Number: CN5033)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been recognized as an accredited testing laboratory.

- **ISED (CAB Identifier: CN0020)**

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. EMC Laboratory has been recognized by Innovation, Science and Economic Development Canada (ISED) as an accredited testing laboratory

- **VCCI (Member No.: 3061)**

The 3m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-13868, C-14336, T-12221, G-10830 respectively.

## 4 Test Standards and Limits

### 4.1 FCC Radiofrequency radiation exposure limits:

According to §1.1310, the limit for general population/uncontrolled exposures

Frequency	Power density(mW/cm <sup>2</sup> )	Averaging time(minutes)
300MHz~1.5GHz	$f/1500$	30
1.5GHz~100GHz	1.0	30

### 4.2 IC Radiofrequency radiation exposure limits:

According to RSS-102 section 2.5.2, RF exposure evaluation is required if the separation distance between the user and/or bystander and the device's radiating element is greater than 20 cm, except when the device operates as follows:

below 20 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 1 W (adjusted for tune-up tolerance);

- at or above 20 MHz and below 48 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than  $4.49/f^{0.5}$  W (adjusted for tune-up tolerance), where  $f$  is in MHz;
- at or above 48 MHz and below 300 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 0.6 W (adjusted for tune-up tolerance);
- at or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than  $1.31 \times 10^{-2} f^{0.6834}$  W (adjusted for tune-up tolerance), where  $f$  is in MHz;
- at or above 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 5 W (adjusted for tune-up tolerance).

For 2.4G device, the limit of worse case is 2.68 W

## 5 Measurement and Calculation

### 5.1 Maximum transmit power

The Power Data is based on the RF Test Report SHEM200600476601

Test Mode	Test Channel	Ant	Power [dBm]	Power [mW]
11B	2412	Ant1	16.41	43.75
11B	2437	Ant1	16.81	47.97
11B	2462	Ant1	16.85	<b>48.42</b>
11G	2412	Ant1	14.81	30.27
11G	2437	Ant1	15.23	33.34
11G	2462	Ant1	15.39	34.59
11N20SISO	2412	Ant1	14.73	29.72
11N20SISO	2437	Ant1	15.13	32.58
11N20SISO	2462	Ant1	15.37	34.43
11N40SISO	2422	Ant1	13.96	24.89
11N40SISO	2437	Ant1	14.17	26.12
11N40SISO	2452	Ant1	14.26	26.67

Remark: The tune-up power is 17.5dBm(56.23mW)

## 5.2 MPE Calculation

For FCC:

According to the formula  $S = P / 4\pi R^2$ , we can calculate S which is MPE.

Note:

- 1) P (mW)
- 2) R = distance to the center of radiation of antenna (in meter) = 20cm
- 3) MPE limit = 1mW/cm<sup>2</sup>

The max. antenna gain is 1 dBi

Max. Conducted Power P(mW)	Gain in Linear Scale G	Operation Distance R(cm)	Power Density (mW/cm <sup>2</sup> )	Limit (mW/cm <sup>2</sup> )	Result
56.23	1.259	20	0.01408	1	Pass

For IC:

$$E.I.R.P. = P \cdot G = 0.05623 \times 1.259 = 0.07W < 2.68W$$

So the device is exclusion from SAR test.

**--End of the Report--**